

<b>Notice of References Cited</b>	Application/Control No. 10/828,549	Applicant(s)/Patent Under Reexamination LU ET AL.	
	Examiner Hana A. Sanei	Art Unit 2879	Page 1 of 1

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*	B	US-2004/0027059	02-2004	Tsutsui, Tetsuo	313/504
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